

**Notice of References Cited**

Application/Control No.

09/274,010

Applicant(s)/Patent Under  
Reexamination  
CLINE ET AL.

Examiner

Shervin Nakhjavan

Art Unit

2621

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*		Document Number	Date	Name	Classification	
		Country Code-Number-Kind Code	MM-YYYY			
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✓	B	US-5,936,628-	08-1999	Kitamura et al.	345	420
✓	C	US-5,931,667-	08-1999	Papandreas	433	8
✓	D	US-5,726,705-	03-1998	Imanishi et al.	348	92
✓	E	US-5,163,094-	11-1992	Prokoski et al.	382	118
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	R	- -					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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